

Search Notes

Application No.

10/617,702

Examiner

David E. Bochna

Applicant(s)

BAICH ET AL.

Art Unit

3679

SEARCHED

Class	Subclass	Date	Examiner
285	354	5/24/2004	DB
	353		
	386		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR